Search Notes



Applica	tion/	Contro	l No
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Reexamination

Applicant(s)/Patent Under

ISHIKAWA ET AL.

Examiner

SHIN-HON CHEN

2431

Art Unit

SEARCHED

Class	Subclass	Date	Examiner
713	150	11/23/09	S.C.
726	3, 5	11/23/09	S.C.
709	224, 245	11/23/09	S.C.

SEARCH NOTES

Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search)	11/23/09	S.C.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
713	150	3/25/10	S.C.
726	3,5	3/25/10	S.C.
709	224, 245	3/25/10	S.C.

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